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Understanding <u>Embedded - FPGAs (Field Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

| Details | |
|--------------------------------|--|
| Product Status | Obsolete |
| Number of LABs/CLBs | 768 |
| Number of Logic Elements/Cells | - |
| Total RAM Bits | - |
| Number of I/O | 130 |
| Number of Gates | 12000 |
| Voltage - Supply | 3V ~ 3.6V, 4.75V ~ 5.25V |
| Mounting Type | Surface Mount |
| Operating Temperature | -40°C ~ 85°C (TA) |
| Package / Case | 208-BFQFP |
| Supplier Device Package | 208-PQFP (28x28) |
| Purchase URL | https://www.e-xfl.com/product-detail/microsemi/a54sx08-2pq208i |

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

The R-cell contains a flip-flop featuring asynchronous clear, asynchronous preset, and clock enable (using the S0 and S1 lines) control signals (Figure 1-2). The R-cell registers feature programmable clock polarity selectable on a register-by-register basis. This provides additional

flexibility while allowing mapping of synthesized functions into the SX FPGA. The clock source for the R-cell can be chosen from either the hardwired clock or the routed clock.

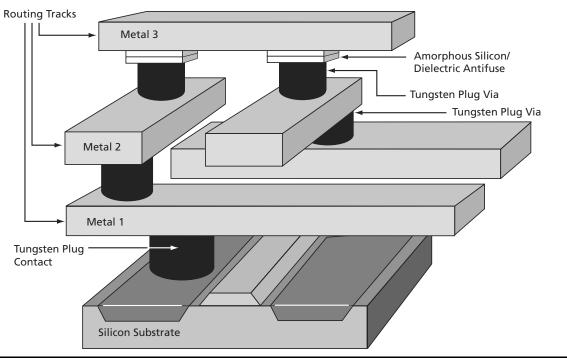


Figure 1-1 • SX Family Interconnect Elements

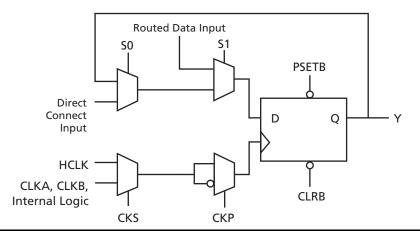


Figure 1-2 • R-Cell

The C-cell implements a range of combinatorial functions up to 5-inputs (Figure 1-3 on page 1-3). Inclusion of the DB input and its associated inverter function dramatically increases the number of combinatorial functions that can be implemented in a single module from 800 options in previous architectures to more than 4,000 in the SX architecture. An example of the improved flexibility

enabled by the inversion capability is the ability to integrate a 3-input exclusive-OR function into a single C-cell. This facilitates construction of 9-bit parity-tree functions with 2 ns propagation delays. At the same time, the C-cell structure is extremely synthesis friendly, simplifying the overall design and reducing synthesis time.

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A54SX16P DC Specifications (3.3 V PCI Operation)

Table 1-8 • A54SX16P DC Specifications (3.3 V PCI Operation)

| Symbol | Parameter | Condition | Min. | Max. | Units |
|--------------------|--|----------------------------|--------------------|--------------------|-------|
| V_{CCA} | Supply Voltage for Array | | 3.0 | 3.6 | V |
| V_{CCR} | Supply Voltage required for Internal Biasing | | 3.0 | 3.6 | V |
| V_{CCI} | Supply Voltage for I/Os | | 3.0 | 3.6 | V |
| V_{IH} | Input High Voltage | | 0.5V _{CC} | $V_{CC} + 0.5$ | V |
| V_{IL} | Input Low Voltage | | -0.5 | 0.3V _{CC} | V |
| I _{IPU} | Input Pull-up Voltage ¹ | | 0.7V _{CC} | | V |
| I _{IL} | Input Leakage Current ² | $0 < V_{IN} < V_{CC}$ | | ±10 | μΑ |
| V_{OH} | Output High Voltage | I _{OUT} = -500 μA | 0.9V _{CC} | | V |
| V_{OL} | Output Low Voltage | I _{OUT} = 1500 μA | | 0.1V _{CC} | V |
| C _{IN} | Input Pin Capacitance ³ | | | 10 | pF |
| C _{CLK} | CLK Pin Capacitance | | 5 | 12 | pF |
| C _{IDSEL} | IDSEL Pin Capacitance ⁴ | | | 8 | pF |

Notes:

- 1. This specification should be guaranteed by design. It is the minimum voltage to which pull-up resistors are calculated to pull a floated network. Applications sensitive to static power utilization should assure that the input buffer is conducting minimum current at this input voltage.
- 2. Input leakage currents include hi-Z output leakage for all bidirectional buffers with tristate outputs.
- 3. Absolute maximum pin capacitance for a PCI input is 10 pF (except for CLK).
- 4. Lower capacitance on this input-only pin allows for non-resistive coupling to AD[xx].

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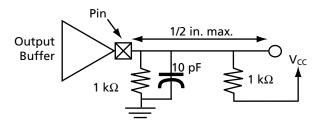
A54SX16P AC Specifications (3.3 V PCI Operation)

Table 1-9 • A54SX16P AC Specifications (3.3 V PCI Operation)

| Symbol | Parameter | Condition | Min. | Max. | Units |
|---------------------|------------------------------------|---|---|---------------------|-------|
| | Switching Current High | $0 < V_{OUT} \le 0.3 V_{CC}^{1}$ | | | mA |
| | | $0.3V_{CC} \le V_{OUT} < 0.9V_{CC}^{1}$ | –12V _{CC} | | mA |
| I _{OH(AC)} | | $0.7V_{CC} < V_{OUT} < V_{CC}^{1, 2}$ | -17.1 + (V _{CC} - V _{OUT}) | EQ 1-3 on page 1-14 | |
| | (Test Point) | $V_{OUT} = 0.7V_{CC}^2$ | | -32V _{CC} | mA |
| | Switching Current High | $V_{CC} > V_{OUT} \ge 0.6 V_{CC}^{1}$ | | | mA |
| 1 | | $0.6V_{CC} > V_{OUT} > 0.1V_{CC}^{1}$ | 16V _{CC} | | mA |
| I _{OL(AC)} | | $0.18V_{CC} > V_{OUT} > 0^{1, 2}$ | 26.7V _{OUT} | EQ 1-4 on page 1-14 | mA |
| | (Test Point) | $V_{OUT} = 0.18V_{CC}^2$ | | 38V _{CC} | |
| I _{CL} | Low Clamp Current | $-3 < V_{IN} \le -1$ | -25 + (V _{IN} + 1)/0.015 | | mA |
| I _{CH} | High Clamp Current | $-3 < V_{IN} \le -1$ | 25 + (V _{IN} – V _{OUT} – 1)/0.015 | | mA |
| slew _R | Output Rise Slew Rate ³ | 0.2V _{CC} to 0.6V _{CC} load | 1 | 4 | V/ns |
| slew _F | Output Fall Slew Rate ³ | 0.6V _{CC} to 0.2V _{CC} load | 1 | 4 | V/ns |

Notes:

- 1. Refer to the V/I curves in Figure 1-10 on page 1-14. Switching current characteristics for REQ# and GNT# are permitted to be one half of that specified here; i.e., half size output drivers may be used on these signals. This specification does not apply to CLK and RST# which are system outputs. "Switching Current High" specification are not relevant to SERR#, INTA#, INTB#, INTC#, and INTD# which are open drain outputs.
- 2. Maximum current requirements must be met as drivers pull beyond the last step voltage. Equations defining these maximums (C and D) are provided with the respective diagrams in Figure 1-10 on page 1-14. The equation defined maxima should be met by design. In order to facilitate component testing, a maximum current test point is defined for each side of the output driver.
- 3. This parameter is to be interpreted as the cumulative edge rate across the specified range, rather than the instantaneous rate at any point within the transition range. The specified load (diagram below) is optional; i.e., the designer may elect to meet this parameter with an unloaded output per the latest revision of the PCI Local Bus Specification. However, adherence to both maximum and minimum parameters is required (the maximum is no longer simply a guideline). Rise slew rate does not apply to open drain outputs.



Evaluating Power in SX Devices

A critical element of system reliability is the ability of electronic devices to safely dissipate the heat generated during operation. The thermal characteristics of a circuit depend on the device and package used, the operating temperature, the operating current, and the system's ability to dissipate heat.

You should complete a power evaluation early in the design process to help identify potential heat-related problems in the system and to prevent the system from exceeding the device's maximum allowed junction temperature.

The actual power dissipated by most applications is significantly lower than the power the package can dissipate. However, a thermal analysis should be performed for all projects. To perform a power evaluation, follow these steps:

- Estimate the power consumption of the application.
- Calculate the maximum power allowed for the device and package.
- 3. Compare the estimated power and maximum power values.

Estimating Power Consumption

The total power dissipation for the SX family is the sum of the DC power dissipation and the AC power dissipation. Use EQ 1-5 to calculate the estimated power consumption of your application.

$$P_{Total} = P_{DC} + P_{AC}$$

EQ 1-5

n

DC Power Dissipation

The power due to standby current is typically a small component of the overall power. The Standby power is shown in Table 1-12 for commercial, worst-case conditions (70°C).

Table 1-12 • Standby Power

| I _{CC} | V _{CC} | Power |
|-----------------|-----------------|---------|
| 4 mA | 3.6 V | 14.4 mW |

The DC power dissipation is defined in EQ 1-6.

$$\begin{split} P_{DC} &= (I_{standby}) \times V_{CCA} + (I_{standby}) \times V_{CCR} + \\ (I_{standby}) \times V_{CCI} + xV_{OL} \times I_{OL} + y(V_{CCI} - V_{OH}) \times V_{OH} \end{split}$$

EQ 1-6

AC Power Dissipation

The power dissipation of the SX Family is usually dominated by the dynamic power dissipation. Dynamic power dissipation is a function of frequency, equivalent capacitance, and power supply voltage. The AC power dissipation is defined in EQ 1-7 and EQ 1-8.

EQ 1-7

$$\begin{split} P_{AC} &= V_{CCA}^2 \times [(m \times C_{EQM} \times f_m)_{Module} + \\ (n \times C_{EQI} \times f_n)_{Input \ Buffer} + (p \times (C_{EQO} + C_L) \times f_p)_{Output \ Buffer} + \\ (0.5 \times (q_1 \times C_{EQCR} \times f_{q_1}) + (r_1 \times f_{q_1}))_{RCLKA} + \\ (0.5 \times (q_2 \times CEQCR \times f_{q_2}) + (r_2 \times f_{q_2}))_{RCLKB} + \\ (0.5 \times (s_1 \times C_{EOHV} \times f_{s_1}) + (C_{EOHF} \times f_{s_1}))_{HCLK}] \end{split}$$

EQ 1-8

Definition of Terms Used in Formula

 $m = Number of logic modules switching at <math>f_m$

Number of input buffers switching at f_n

p = Number of output buffers switching at f_p

q₁ = Number of clock loads on the first routed array clock

q₂ = Number of clock loads on the second routed array clock

x = Number of I/Os at logic low

y = Number of I/Os at logic high

r₁ = Fixed capacitance due to first routed array clock

r₂ = Fixed capacitance due to second routed array clock

s₁ = Number of clock loads on the dedicated array

C_{EOM} = Equivalent capacitance of logic modules in pF

C_{EQI} = Equivalent capacitance of input buffers in pF

C_{EOO} = Equivalent capacitance of output buffers in pF

 C_{EQCR} = Equivalent capacitance of routed array clock in pF

C_{EQHV} = Variable capacitance of dedicated array clock

C_{EOHF} = Fixed capacitance of dedicated array clock

C_I = Output lead capacitance in pF

f_m = Average logic module switching rate in MHz

f_n = Average input buffer switching rate in MHz

f_p = Average output buffer switching rate in MHz

 f_{q1} = Average first routed array clock rate in MHz

f_{q2} = Average second routed array clock rate in MHz

f_{s1} = Average dedicated array clock rate in MHz

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Table 1-13 shows capacitance values for various devices.

Table 1-13 • Capacitance Values for Devices

| | A545X08 | A54SX16 | A54SX16P | A54SX32 |
|------------------------|---------|---------|----------|---------|
| C _{EQM} (pF) | 4.0 | 4.0 | 4.0 | 4.0 |
| C _{EQI} (pF) | 3.4 | 3.4 | 3.4 | 3.4 |
| C _{EQO} (pF) | 4.7 | 4.7 | 4.7 | 4.7 |
| C _{EQCR} (pF) | 1.6 | 1.6 | 1.6 | 1.6 |
| C _{EQHV} | 0.615 | 0.615 | 0.615 | 0.615 |
| C _{EQHF} | 60 | 96 | 96 | 140 |
| r ₁ (pF) | 87 | 138 | 138 | 171 |
| r ₂ (pF) | 87 | 138 | 138 | 171 |

Guidelines for Calculating Power Consumption

The power consumption guidelines are meant to represent worst-case scenarios so that they can be generally used to predict the upper limits of power dissipation. These guidelines are shown in Table 1-14.

Sample Power Calculation

One of the designs used to characterize the SX family was a 528 bit serial-in, serial-out shift register. The design utilized 100 percent of the dedicated flip-flops of an A54SX16P device. A pattern of 0101... was clocked into the device at frequencies ranging from 1 MHz to 200 MHz. Shifting in a series of 0101... caused 50 percent of the flip-flops to toggle from low to high at every clock cycle.

Table 1-14 • Power Consumption Guidelines

| Description | Power Consumption Guidelin | | | | | |
|---|----------------------------|--|--|--|--|--|
| Logic Modules (m) | 20% of modules | | | | | |
| Inputs Switching (n) | # inputs/4 | | | | | |
| Outputs Switching (p) | # outputs/4 | | | | | |
| First Routed Array Clock Loads (q ₁) | 20% of register cells | | | | | |
| Second Routed Array Clock Loads (q ₂) | 20% of register cells | | | | | |
| Load Capacitance (C _L) | 35 pF | | | | | |
| Average Logic Module Switching Rate (f _m) | f/10 | | | | | |
| Average Input Switching Rate (f _n) | f/5 | | | | | |
| Average Output Switching Rate (f _p) | f/10 | | | | | |
| Average First Routed Array Clock Rate (f _{q1}) | f/2 | | | | | |
| Average Second Routed Array Clock Rate (f _{q2}) | f/2 | | | | | |
| Average Dedicated Array Clock Rate (f _{s1}) | f | | | | | |
| Dedicated Clock Array Clock Loads (s ₁) | 20% of regular modules | | | | | |

EQ 1-9

Follow the steps below to estimate power consumption. The values provided for the sample calculation below are for the shift register design above. This method for estimating power consumption is conservative and the actual power consumption of your design may be less than the estimated power consumption.

The total power dissipation for the SX family is the sum of the AC power dissipation and the DC power dissipation.

$$P_{Total} = P_{AC}$$
 (dynamic power) + P_{DC} (static power)

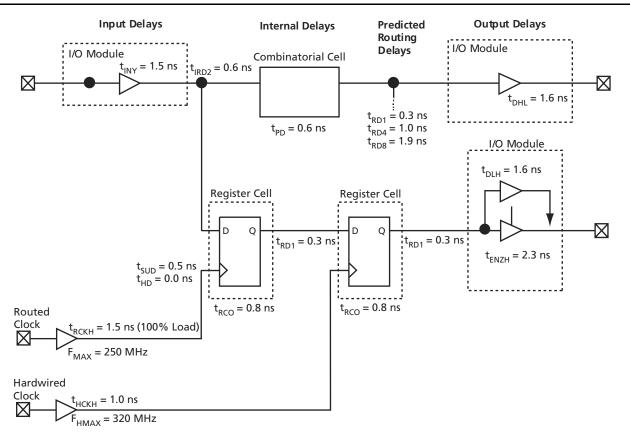
AC Power Dissipation

EQ 1-10

$$\begin{split} P_{AC} &= V_{CCA}^2 \times [(m \times C_{EQM} \times f_m)_{Module} + \\ (n \times C_{EQI} \times f_n)_{Input \ Buffer} + (p \times (C_{EQO} + C_L) \times f_p)_{Output \ Buffer} + \\ (0.5 \ (q_1 \times C_{EQCR} \times f_{q1}) + (r_1 \times f_{q1}))_{RCLKA} + \\ (0.5 \ (q_2 \times C_{EQCR} \times f_{q2}) + (r_2 \times f_{q2}))_{RCLKB} + \\ (0.5 \ (s_1 \times C_{EOHV} \times f_{s1}) + (C_{EOHF} \times f_{s1}))_{HCLK}] \end{split}$$

EQ 1-11

SX Timing Model



Note: Values shown for A54SX08-3, worst-case commercial conditions.

Figure 1-12 • SX Timing Model

Hardwired Clock Routed Clock External Setup = $t_{INY} + t_{IRD1} + t_{SUD} - t_{RCKH}$ External Setup = $t_{INY} + t_{IRD1} + t_{SUD} - t_{HCKH}$ = 1.5 + 0.3 + 0.5 - 1.0 = 1.3 ns= 1.5 + 0.3 + 0.5 - 1.5 = 0.8 nsEQ 1-15 EQ 1-17 Clock-to-Out (Pin-to-Pin) Clock-to-Out (Pin-to-Pin) $= t_{HCKH} + t_{RCO} + t_{RD1} + t_{DHL}$ = $t_{RCKH} + t_{RCO} + t_{RD1} + t_{DHL}$ = 1.0 + 0.8 + 0.3 + 1.6 = 3.7 ns= 1.52 + 0.8 + 0.3 + 1.6 = 4.2 nsEQ 1-16 EQ 1-18

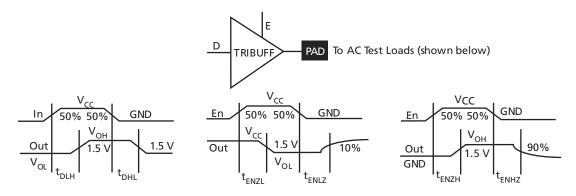


Figure 1-13 • Output Buffer Delays

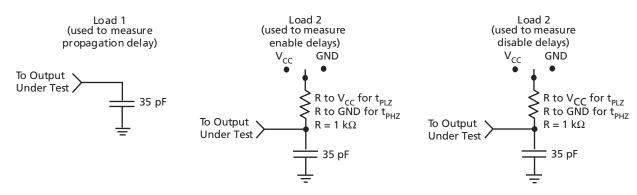


Figure 1-14 • AC Test Loads



Figure 1-15 • Input Buffer Delays

Figure 1-16 • C-Cell Delays

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Table 1-17 • A54SX08 Timing Characteristics (Continued) (Worst-Case Commercial Conditions, V_{CCR} = 4.75 V, V_{CCA}, V_{CCI} = 3.0 V, T_J = 70°C)

| | | '-3' 9 | Speed | '-2' \$ | Speed | '-1' 9 | Speed | 'Std' | Speed | |
|--------------------|---|--------|-------|---------|-------|--------|-------|-------|-------|-------|
| Parameter | Description | Min. | Мах. | Min. | Мах. | Min. | Мах. | Min. | Мах. | Units |
| Dedicated (| Hardwired) Array Clock Network | | | | | | | | | |
| t _{HCKH} | Input LOW to HIGH (pad to R-Cell input) | | 1.0 | | 1.1 | | 1.3 | | 1.5 | ns |
| t_{HCKL} | Input HIGH to LOW (pad to R-Cell input) | | 1.0 | | 1.2 | | 1.4 | | 1.6 | ns |
| t_{HPWH} | Minimum Pulse Width HIGH | 1.4 | | 1.6 | | 1.8 | | 2.1 | | ns |
| t_{HPWL} | Minimum Pulse Width LOW | 1.4 | | 1.6 | | 1.8 | | 2.1 | | ns |
| t _{HCKSW} | Maximum Skew | | 0.1 | | 0.2 | | 0.2 | | 0.2 | ns |
| t _{HP} | Minimum Period | 2.7 | | 3.1 | | 3.6 | | 4.2 | | ns |
| f_{HMAX} | Maximum Frequency | | 350 | | 320 | | 280 | | 240 | MHz |
| Routed Arra | ay Clock Networks | | | | | | | | | |
| t _{RCKH} | Input LOW to HIGH (light load) (pad to R-Cell input) | | 1.3 | | 1.5 | | 1.7 | | 2.0 | ns |
| t _{RCKL} | Input HIGH to LOW (light load) (pad to R-Cell Input) | | 1.4 | | 1.6 | | 1.8 | | 2.1 | ns |
| t _{RCKH} | Input LOW to HIGH (50% load) (pad to R-Cell input) | | 1.4 | | 1.7 | | 1.9 | | 2.2 | ns |
| t _{RCKL} | Input HIGH to LOW (50% load) (pad to R-Cell input) | | 1.5 | | 1.7 | | 2.0 | | 2.3 | ns |
| t _{RCKH} | Input LOW to HIGH (100% load) (pad to R-Cell input) | | 1.5 | | 1.7 | | 1.9 | | 2.2 | ns |
| t_{RCKL} | Input HIGH to LOW (100% load) (pad to R-Cell input) | | 1.5 | | 1.8 | | 2.0 | | 2.3 | ns |
| t _{RPWH} | Min. Pulse Width HIGH | 2.1 | | 2.4 | | 2.7 | | 3.2 | | ns |
| t _{RPWL} | Min. Pulse Width LOW | 2.1 | | 2.4 | | 2.7 | | 3.2 | | ns |
| t _{RCKSW} | Maximum Skew (light load) | | 0.1 | | 0.2 | | 0.2 | | 0.2 | ns |
| t _{RCKSW} | Maximum Skew (50% load) | | 0.3 | | 0.3 | | 0.4 | | 0.4 | ns |
| t _{RCKSW} | Maximum Skew (100% load) | | 0.3 | | 0.3 | | 0.4 | | 0.4 | ns |
| TTL Output | Module Timing1 | | | | | | | | | |
| t _{DLH} | Data-to-Pad LOW to HIGH | | 1.6 | | 1.9 | | 2.1 | | 2.5 | ns |
| t_{DHL} | Data-to-Pad HIGH to LOW | | 1.6 | | 1.9 | | 2.1 | | 2.5 | ns |
| t _{ENZL} | Enable-to-Pad, Z to L | | 2.1 | | 2.4 | | 2.8 | | 3.2 | ns |
| t _{ENZH} | Enable-to-Pad, Z to H | | 2.3 | | 2.7 | | 3.1 | | 3.6 | ns |
| t _{ENLZ} | Enable-to-Pad, L to Z | | 1.4 | | 1.7 | | 1.9 | | 2.2 | ns |

Note:

- 1. For dual-module macros, use $t_{PD}+t_{RD1}+t_{PDn}$, $t_{RCO}+t_{RD1}+t_{PDn}$, or $t_{PD1}+t_{RD1}+t_{SUD}$, whichever is appropriate.
- 2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.

A54SX16P Timing Characteristics

Table 1-19 • A54SX16P Timing Characteristics (Worst-Case Commercial Conditions, V_{CCR} = 4.75 V, V_{CCA},V_{CCI} = 3.0 V, T_J = 70°C)

| | | '-3' \$ | Speed | '-2' \$ | Speed | '-1' Speed | | 'Std' Speed | | |
|---------------------|--------------------------------------|---------|-------|---------|-------|------------|------|-------------|------|-------|
| Parameter | Description | Min. | Мах. | Min. | Max. | Min. | Max. | Min. | Мах. | Units |
| C-Cell Propa | agation Delays ¹ | | | | | | | | | |
| t _{PD} | Internal Array Module | | 0.6 | | 0.7 | | 8.0 | | 0.9 | ns |
| Predicted R | outing Delays ² | | | | | | | | | |
| t _{DC} | FO = 1 Routing Delay, Direct Connect | | 0.1 | | 0.1 | | 0.1 | | 0.1 | ns |
| t _{FC} | FO = 1 Routing Delay, Fast Connect | | 0.3 | | 0.4 | | 0.4 | | 0.5 | ns |
| t _{RD1} | FO = 1 Routing Delay | | 0.3 | | 0.4 | | 0.4 | | 0.5 | ns |
| t _{RD2} | FO = 2 Routing Delay | | 0.6 | | 0.7 | | 8.0 | | 0.9 | ns |
| t _{RD3} | FO = 3 Routing Delay | | 8.0 | | 0.9 | | 1.0 | | 1.2 | ns |
| t _{RD4} | FO = 4 Routing Delay | | 1.0 | | 1.2 | | 1.4 | | 1.6 | ns |
| t _{RD8} | FO = 8 Routing Delay | | 1.9 | | 2.2 | | 2.5 | | 2.9 | ns |
| t _{RD12} | FO = 12 Routing Delay | | 2.8 | | 3.2 | | 3.7 | | 4.3 | ns |
| R-Cell Timir | ng | | | | | | | | | |
| t _{RCO} | Sequential Clock-to-Q | | 0.9 | | 1.1 | | 1.3 | | 1.4 | ns |
| t _{CLR} | Asynchronous Clear-to-Q | | 0.5 | | 0.6 | | 0.7 | | 0.8 | ns |
| t _{PRESET} | Asynchronous Preset-to-Q | | 0.7 | | 8.0 | | 0.9 | | 1.0 | ns |
| t _{SUD} | Flip-Flop Data Input Set-Up | 0.5 | | 0.5 | | 0.7 | | 0.8 | | ns |
| t _{HD} | Flip-Flop Data Input Hold | 0.0 | | 0.0 | | 0.0 | | 0.0 | | ns |
| t _{WASYN} | Asynchronous Pulse Width | 1.4 | | 1.6 | | 1.8 | | 2.1 | | ns |
| Input Modu | ıle Propagation Delays | | | | | | | | | |
| t _{INYH} | Input Data Pad-to-Y HIGH | | 1.5 | | 1.7 | | 1.9 | | 2.2 | ns |
| t _{INYL} | Input Data Pad-to-Y LOW | | 1.5 | | 1.7 | | 1.9 | | 2.2 | ns |
| Predicted In | nput Routing Delays ² | | | | | | | | | |
| t _{IRD1} | FO = 1 Routing Delay | | 0.3 | | 0.4 | | 0.4 | | 0.5 | ns |
| t _{IRD2} | FO = 2 Routing Delay | | 0.6 | | 0.7 | | 8.0 | | 0.9 | ns |
| t _{IRD3} | FO = 3 Routing Delay | | 8.0 | | 0.9 | | 1.0 | | 1.2 | ns |
| t _{IRD4} | FO = 4 Routing Delay | | 1.0 | | 1.2 | | 1.4 | | 1.6 | ns |
| t _{IRD8} | FO = 8 Routing Delay | | 1.9 | | 2.2 | | 2.5 | | 2.9 | ns |
| t _{IRD12} | FO = 12 Routing Delay | | 2.8 | | 3.2 | | 3.7 | | 4.3 | ns |

Note:

- 1. For dual-module macros, use t_{PD} + t_{RD1} + t_{PDn} , t_{RCO} + t_{RD1} + t_{PDn} , or t_{PD1} + t_{RD1} + t_{SUD} , whichever is appropriate.
- 2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.

3. Delays based on 10 pF loading.

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Table 1-19 • A54SX16P Timing Characteristics (Continued) (Worst-Case Commercial Conditions, V_{CCR} = 4.75 V, V_{CCA},V_{CCI} = 3.0 V, T_J = 70°C)

| | | '-3' \$ | peed | '-2' \$ | Speed | '-1' \$ | Speed | 'Std' | Speed | |
|--------------------|---|---------|------|---------|-------|---------|-------|-------|-------|-------|
| Parameter | Description | Min. | Max. | Min. | Max. | Min. | Max. | Min. | Мах. | Units |
| Dedicated (| Hardwired) Array Clock Network | | | | | | | | | |
| t _{HCKH} | Input LOW to HIGH (pad to R-Cell input) | | 1.2 | | 1.4 | | 1.5 | | 1.8 | ns |
| t _{HCKL} | Input HIGH to LOW (pad to R-Cell input) | | 1.2 | | 1.4 | | 1.6 | | 1.9 | ns |
| t _{HPWH} | Minimum Pulse Width HIGH | 1.4 | | 1.6 | | 1.8 | | 2.1 | | ns |
| t _{HPWL} | Minimum Pulse Width LOW | 1.4 | | 1.6 | | 1.8 | | 2.1 | | ns |
| t _{HCKSW} | Maximum Skew | | 0.2 | | 0.2 | | 0.3 | | 0.3 | ns |
| t _{HP} | Minimum Period | 2.7 | | 3.1 | | 3.6 | | 4.2 | | ns |
| f _{HMAX} | Maximum Frequency | | 350 | | 320 | | 280 | | 240 | MHz |
| Routed Arra | ay Clock Networks | | | | | | | | | |
| t _{RCKH} | Input LOW to HIGH (light load) (pad to R-Cell input) | | 1.6 | | 1.8 | | 2.1 | | 2.5 | ns |
| t _{RCKL} | Input HIGH to LOW (Light Load) (pad to R-Cell input) | | 1.8 | | 2.0 | | 2.3 | | 2.7 | ns |
| t _{RCKH} | Input LOW to HIGH (50% load) (pad to R-Cell input) | | 1.8 | | 2.1 | | 2.5 | | 2.8 | ns |
| t _{RCKL} | Input HIGH to LOW (50% load) (pad to R-Cell input) | | 2.0 | | 2.2 | | 2.5 | | 3.0 | ns |
| t _{RCKH} | Input LOW to HIGH (100% load) (pad to R-Cell input) | | 1.8 | | 2.1 | | 2.4 | | 2.8 | ns |
| t _{RCKL} | Input HIGH to LOW (100% load) (pad to R-Cell input) | | 2.0 | | 2.2 | | 2.5 | | 3.0 | ns |
| t _{RPWH} | Min. Pulse Width HIGH | 2.1 | | 2.4 | | 2.7 | | 3.2 | | ns |
| t _{RPWL} | Min. Pulse Width LOW | 2.1 | | 2.4 | | 2.7 | | 3.2 | | ns |
| t _{RCKSW} | Maximum Skew (light load) | | 0.5 | | 0.5 | | 0.5 | | 0.7 | ns |
| t _{RCKSW} | Maximum Skew (50% load) | | 0.5 | | 0.6 | | 0.7 | | 8.0 | ns |
| t _{RCKSW} | Maximum Skew (100% load) | | 0.5 | | 0.6 | | 0.7 | | 8.0 | ns |
| TTL Output | Module Timing | | | | | | | | | |
| t _{DLH} | Data-to-Pad LOW to HIGH | | 2.4 | | 2.8 | | 3.1 | | 3.7 | ns |
| t _{DHL} | Data-to-Pad HIGH to LOW | | 2.3 | | 2.9 | | 3.2 | | 3.8 | ns |
| t _{ENZL} | Enable-to-Pad, Z to L | | 3.0 | | 3.4 | | 3.9 | | 4.6 | ns |
| t _{ENZH} | Enable-to-Pad, Z to H | | 3.3 | | 3.8 | | 4.3 | | 5.0 | ns |
| t _{ENLZ} | Enable-to-Pad, L to Z | | 2.3 | | 2.7 | | 3.0 | | 3.5 | ns |
| t _{ENHZ} | Enable-to-Pad, H to Z | | 2.8 | | 3.2 | | 3.7 | | 4.3 | ns |

Note:

- 1. For dual-module macros, use t_{PD} + t_{RD1} + t_{PDn} , t_{RCO} + t_{RD1} + t_{PDn} , or t_{PD1} + t_{RD1} + t_{SUD} , whichever is appropriate.
- 2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- 3. Delays based on 10 pF loading.



A54SX32 Timing Characteristics

Table 1-20 • A54SX32 Timing Characteristics (Worst-Case Commercial Conditions, V_{CCR}= 4.75 V, V_{CCA}, V_{CCI} = 3.0 V, T_J = 70°C)

| | | '-3' \$ | Speed | '-2' 9 | Speed | '-1' 9 | Speed | 'Std' | Speed | |
|---------------------|--------------------------------------|---------|-------|--------|-------|--------|-------|-------|-------|-------|
| Parameter | Description | Min. | Мах. | Min. | Мах. | Min. | Мах. | Min. | Мах. | Units |
| C-Cell Propa | agation Delays ¹ | | | | | | | | | |
| t _{PD} | Internal Array Module | | 0.6 | | 0.7 | | 8.0 | | 0.9 | ns |
| Predicted R | outing Delays ² | | | | | | | | | |
| t _{DC} | FO = 1 Routing Delay, Direct Connect | | 0.1 | | 0.1 | | 0.1 | | 0.1 | ns |
| t _{FC} | FO = 1 Routing Delay, Fast Connect | | 0.3 | | 0.4 | | 0.4 | | 0.5 | ns |
| t _{RD1} | FO = 1 Routing Delay | | 0.3 | | 0.4 | | 0.4 | | 0.5 | ns |
| t _{RD2} | FO = 2 Routing Delay | | 0.7 | | 8.0 | | 0.9 | | 1.0 | ns |
| t _{RD3} | FO = 3 Routing Delay | | 1.0 | | 1.2 | | 1.4 | | 1.6 | ns |
| t _{RD4} | FO = 4 Routing Delay | | 1.4 | | 1.6 | | 1.8 | | 2.1 | ns |
| t _{RD8} | FO = 8 Routing Delay | | 2.7 | | 3.1 | | 3.5 | | 4.1 | ns |
| t _{RD12} | FO = 12 Routing Delay | | 4.0 | | 4.7 | | 5.3 | | 6.2 | ns |
| R-Cell Timir | ng | | | | | | | | | |
| t _{RCO} | Sequential Clock-to-Q | | 0.8 | | 1.1 | | 1.3 | | 1.4 | ns |
| t _{CLR} | Asynchronous Clear-to-Q | | 0.5 | | 0.6 | | 0.7 | | 8.0 | ns |
| t _{PRESET} | Asynchronous Preset-to-Q | | 0.7 | | 8.0 | | 0.9 | | 1.0 | ns |
| t _{SUD} | Flip-Flop Data Input Set-Up | 0.5 | | 0.6 | | 0.7 | | 0.8 | | ns |
| t _{HD} | Flip-Flop Data Input Hold | 0.0 | | 0.0 | | 0.0 | | 0.0 | | ns |
| t _{WASYN} | Asynchronous Pulse Width | 1.4 | | 1.6 | | 1.8 | | 2.1 | | ns |
| Input Modu | ıle Propagation Delays | | | | | | | | | |
| t _{INYH} | Input Data Pad-to-Y HIGH | | 1.5 | | 1.7 | | 1.9 | | 2.2 | ns |
| t _{INYL} | Input Data Pad-to-Y LOW | | 1.5 | | 1.7 | | 1.9 | | 2.2 | ns |
| Predicted In | nput Routing Delays ² | | | | | | | | | |
| t _{IRD1} | FO = 1 Routing Delay | | 0.3 | | 0.4 | | 0.4 | | 0.5 | ns |
| t _{IRD2} | FO = 2 Routing Delay | | 0.7 | | 8.0 | | 0.9 | | 1.0 | ns |
| t _{IRD3} | FO = 3 Routing Delay | | 1.0 | | 1.2 | | 1.4 | | 1.6 | ns |
| t _{IRD4} | FO = 4 Routing Delay | | 1.4 | | 1.6 | | 1.8 | | 2.1 | ns |
| t _{IRD8} | FO = 8 Routing Delay | | 2.7 | | 3.1 | | 3.5 | | 4.1 | ns |
| t _{IRD12} | FO = 12 Routing Delay | | 4.0 | | 4.7 | | 5.3 | | 6.2 | ns |

Note:

- 1. For dual-module macros, use t_{PD} + t_{RD1} + $t_{PDn'}$ t_{RCO} + t_{RD1} + t_{PDn} , or t_{PD1} + t_{RD1} + t_{SUD} , whichever is appropriate.
- 2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- 3. Delays based on 35 pF loading, except t_{ENZL} and t_{ENZH} . For t_{ENZL} and t_{ENZH} the loading is 5 pF.



Pin Description

CLKA/B Clock A and B

These pins are 3.3 V / 5.0 V PCI/TTL clock inputs for clock distribution networks. The clock input is buffered prior to clocking the R-cells. If not used, this pin must be set LOW or HIGH on the board. It must not be left floating. (For A54SX72A, these clocks can be configured as bidirectional.)

GND Ground

LOW supply voltage.

HCLK Dedicated (hardwired) Array Clock

This pin is the 3.3 V / 5.0 V PCI/TTL clock input for sequential modules. This input is directly wired to each R-cell and offers clock speeds independent of the number of R-cells being driven. If not used, this pin must be set LOW or HIGH on the board. It must not be left floating.

I/O Input/Output

The I/O pin functions as an input, output, tristate, or bidirectional buffer. Based on certain configurations, input and output levels are compatible with standard TTL, LVTTL, 3.3 V PCI or 5.0 V PCI specifications. Unused I/O pins are automatically tristated by the Designer Series software.

NC No Connection

This pin is not connected to circuitry within the device.

PRA, I/O Probe A

The Probe A pin is used to output data from any userdefined design node within the device. This independent diagnostic pin can be used in conjunction with the Probe B pin to allow real-time diagnostic output of any signal path within the device. The Probe A pin can be used as a user-defined I/O when verification has been completed. The pin's probe capabilities can be permanently disabled to protect programmed design confidentiality.

PRB. I/O Probe B

The Probe B pin is used to output data from any node within the device. This diagnostic pin can be used in conjunction with the Probe A pin to allow real-time diagnostic output of any signal path within the device. The Probe B pin can be used as a user-defined I/O when verification has been completed. The pin's probe capabilities can be permanently disabled to protect programmed design confidentiality.

TCK Test Clock

Test clock input for diagnostic probe and device programming. In flexible mode, TCK becomes active when the TMS pin is set LOW (refer to Table 1-2 on page 1-6). This pin functions as an I/O when the boundary scan state machine reaches the "logic reset" state.

TDI Test Data Input

Serial input for boundary scan testing and diagnostic probe. In flexible mode, TDI is active when the TMS pin is set LOW (refer to Table 1-2 on page 1-6). This pin functions as an I/O when the boundary scan state machine reaches the "logic reset" state.

TDO Test Data Output

Serial output for boundary scan testing. In flexible mode, TDO is active when the TMS pin is set LOW (refer to Table 1-2 on page 1-6). This pin functions as an I/O when the boundary scan state machine reaches the "logic reset" state.

TMS Test Mode Select

The TMS pin controls the use of the IEEE 1149.1 Boundary Scan pins (TCK, TDI, TDO). In flexible mode when the TMS pin is set LOW, the TCK, TDI, and TDO pins are boundary scan pins (refer to Table 1-2 on page 1-6). Once the boundary scan pins are in test mode, they will remain in that mode until the internal boundary scan state machine reaches the "logic reset" state. At this point, the boundary scan pins will be released and will function as regular I/O pins. The "logic reset" state is reached 5 TCK cycles after the TMS pin is set HIGH. In dedicated test mode, TMS functions as specified in the IEEE 1149.1 specifications.

V_{CCI} Supply Voltage

Supply voltage for I/Os. See Table 1-1 on page 1-5.

V_{CCA} Supply Voltage

Supply voltage for Array. See Table 1-1 on page 1-5.

V_{CCR} Supply Voltage

Supply voltage for input tolerance (required for internal biasing). See Table 1-1 on page 1-5.

Package Pin Assignments

84-Pin PLCC

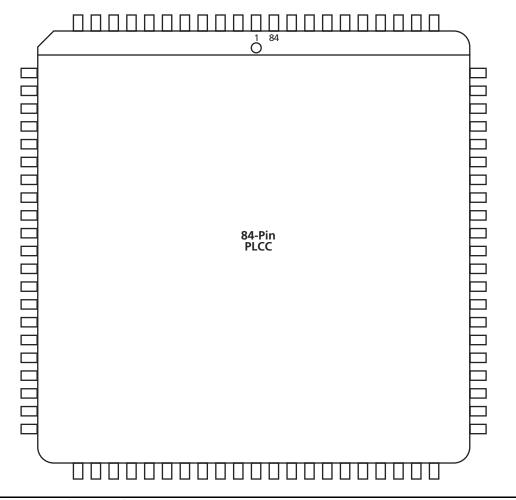


Figure 2-1 • 84-Pin PLCC (Top View)

Note

For Package Manufacturing and Environmental information, visit the Package Resource center at http://www.actel.com/products/rescenter/package/index.html.

v3.2 2-1

| Pin Number A54SX08 Function 1 V _{CCR} 2 GND 3 V _{CCA} 4 PRA, I/O 5 I/O 6 I/O 7 V _{CCI} 8 I/O 9 I/O 10 I/O 11 TCK, I/O 12 TDI, I/O 13 I/O 14 I/O 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O 20 I/O | |
|--|--|
| 2 GND 3 V _{CCA} 4 PRA, VO 5 VO 6 VO 7 V _{CCI} 8 VO 9 VO 10 I/O 11 TCK, VO 12 TDI, I/O 13 I/O 14 I/O 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O | |
| 3 V _{CCA} 4 PRA, I/O 5 I/O 6 I/O 7 V _{CCI} 8 I/O 9 I/O 10 I/O 11 TCK, I/O 12 TDI, I/O 13 I/O 14 I/O 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O | |
| 4 PRA, I/O 5 I/O 6 I/O 7 V _{CCI} 8 I/O 9 I/O 10 I/O 11 TCK, I/O 12 TDI, I/O 13 I/O 14 I/O 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O | |
| 5 | |
| 6 | |
| 7 V _{CCI} 8 VO 9 VO 10 VO 11 TCK, VO 12 TDI, VO 13 VO 14 VO 15 VO 16 TMS 17 VO 18 VO 20 VO | |
| 8 | |
| 9 | |
| 10 | |
| 11 TCK, I/O 12 TDI, I/O 13 I/O 14 I/O 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O 20 I/O | |
| 12 TDI, I/O 13 I/O 14 I/O 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O 20 I/O | |
| 13 I/O 14 I/O 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O 20 I/O | |
| 14 I/O 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O 20 I/O | |
| 15 I/O 16 TMS 17 I/O 18 I/O 19 I/O 20 I/O | |
| 16 TMS 17 I/O 18 I/O 19 I/O 20 I/O | |
| 17 I/O 18 I/O 19 I/O 20 I/O | |
| 18 I/O 19 I/O 20 I/O | |
| 19 I/O 20 I/O | |
| 20 I/O | |
| | |
| 21 1/0 | |
| Z1 I/U | |
| 22 I/O | |
| 23 1/0 | |
| 24 I/O | |
| 25 I/O | |
| 26 I/O | |
| 27 GND | |
| 28 V _{CCI} | |
| 29 1/0 | |
| 30 I/O | |
| 31 1/0 | |
| 32 I/O | |
| 33 1/0 | |
| 34 1/0 | |
| 35 I/O | |

| 84-Pin PLCC | | | | | | | |
|-------------|------------------|--|--|--|--|--|--|
| A54SX08 | | | | | | | |
| Pin Number | Function | | | | | | |
| 36 | 1/0 | | | | | | |
| 37 | I/O | | | | | | |
| 38 | I/O | | | | | | |
| 39 | I/O | | | | | | |
| 40 | PRB, I/O | | | | | | |
| 41 | V_{CCA} | | | | | | |
| 42 | GND | | | | | | |
| 43 | V_{CCR} | | | | | | |
| 44 | I/O | | | | | | |
| 45 | HCLK | | | | | | |
| 46 | I/O | | | | | | |
| 47 | I/O | | | | | | |
| 48 | I/O | | | | | | |
| 49 | I/O | | | | | | |
| 50 | I/O | | | | | | |
| 51 | I/O | | | | | | |
| 52 | TDO, I/O | | | | | | |
| 53 | I/O | | | | | | |
| 54 | I/O | | | | | | |
| 55 | I/O | | | | | | |
| 56 | I/O | | | | | | |
| 57 | I/O | | | | | | |
| 58 | I/O | | | | | | |
| 59 | V_{CCA} | | | | | | |
| 60 | V _{CCI} | | | | | | |
| 61 | GND | | | | | | |
| 62 | I/O | | | | | | |
| 63 | I/O | | | | | | |
| 64 | I/O | | | | | | |
| 65 | I/O | | | | | | |
| 66 | I/O | | | | | | |
| 67 | I/O | | | | | | |
| 68 | V_{CCA} | | | | | | |
| 69 | GND | | | | | | |
| 70 | I/O | | | | | | |

| 84-Pin PLCC | | |
|-------------|---------------------|--|
| Pin Number | A54SX08 Function | |
| 71 | I/O | |
| 72 | I/O | |
| 73 | I/O | |
| 74 | I/O | |
| 75 | I/O | |
| 76 | I/O | |
| 77 | I/O | |
| 78 | I/O | |
| 79 | I/O | |
| 80 | I/O | |
| 81 | I/O | |
| 82 | I/O | |
| 83 | CLKA | |
| 84 | CLKB | |

2-2 v3.2

| 208-Pin PQFP | | | |
|--------------|---------------------|----------------------------------|---------------------|
| Pin Number | A54SX08 Function | A54SX16, A54SX16P Function | A54SX32 Function |
| 1 | GND | GND | GND |
| 2 | TDI, I/O | TDI, I/O | TDI, I/O |
| 3 | I/O | 1/0 | I/O |
| 4 | NC | 1/0 | I/O |
| 5 | I/O | 1/0 | I/O |
| 6 | NC | 1/0 | I/O |
| 7 | I/O | 1/0 | I/O |
| 8 | I/O | 1/0 | I/O |
| 9 | I/O | 1/0 | I/O |
| 10 | I/O | 1/0 | I/O |
| 11 | TMS | TMS | TMS |
| 12 | V _{CCI} | V _{CCI} | V _{CCI} |
| 13 | I/O | 1/0 | I/O |
| 14 | NC | 1/0 | I/O |
| 15 | I/O | I/O | I/O |
| 16 | I/O | I/O | I/O |
| 17 | NC | 1/0 | I/O |
| 18 | I/O | 1/0 | I/O |
| 19 | I/O | 1/0 | I/O |
| 20 | NC | 1/0 | I/O |
| 21 | I/O | I/O | I/O |
| 22 | I/O | I/O | I/O |
| 23 | NC | I/O | I/O |
| 24 | I/O | I/O | I/O |
| 25 | V_{CCR} | V_{CCR} | V_{CCR} |
| 26 | GND | GND | GND |
| 27 | V_{CCA} | V _{CCA} | V_{CCA} |
| 28 | GND | GND | GND |
| 29 | I/O | 1/0 | I/O |
| 30 | I/O | 1/0 | I/O |
| 31 | NC | 1/0 | I/O |
| 32 | I/O | I/O | I/O |
| 33 | I/O | I/O | I/O |
| 34 | I/O | I/O | I/O |
| 35 | NC | I/O | I/O |
| 36 | I/O | I/O | I/O |

| 208-Pin PQFP | | | |
|--------------|---------------------|----------------------------------|---------------------|
| Pin Number | A54SX08 Function | A54SX16, A54SX16P Function | A54SX32 Function |
| 37 | I/O | I/O | I/O |
| 38 | I/O | I/O | I/O |
| 39 | NC | I/O | I/O |
| 40 | V _{CCI} | V _{CCI} | V _{CCI} |
| 41 | V_{CCA} | V_{CCA} | V_{CCA} |
| 42 | I/O | I/O | I/O |
| 43 | I/O | I/O | I/O |
| 44 | I/O | I/O | I/O |
| 45 | I/O | I/O | I/O |
| 46 | I/O | I/O | I/O |
| 47 | I/O | I/O | I/O |
| 48 | NC | I/O | I/O |
| 49 | I/O | I/O | I/O |
| 50 | NC | I/O | I/O |
| 51 | I/O | I/O | I/O |
| 52 | GND | GND | GND |
| 53 | I/O | 1/0 | I/O |
| 54 | I/O | 1/0 | I/O |
| 55 | I/O | I/O | I/O |
| 56 | I/O | I/O | I/O |
| 57 | I/O | I/O | I/O |
| 58 | I/O | I/O | I/O |
| 59 | I/O | I/O | I/O |
| 60 | V _{CCI} | V _{CCI} | V _{CCI} |
| 61 | NC | I/O | I/O |
| 62 | I/O | I/O | I/O |
| 63 | I/O | I/O | I/O |
| 64 | NC | I/O | I/O |
| 65* | I/O | I/O | NC* |
| 66 | I/O | I/O | I/O |
| 67 | NC | I/O | I/O |
| 68 | I/O | I/O | I/O |
| 69 | I/O | I/O | I/O |
| 70 | NC | I/O | I/O |
| 71 | I/O | I/O | I/O |
| 72 | I/O | I/O | I/O |

Note: * Note that Pin 65 in the A54SX32—PQ208 is a no connect (NC).

2-4 v3.2

100-Pin VQFP

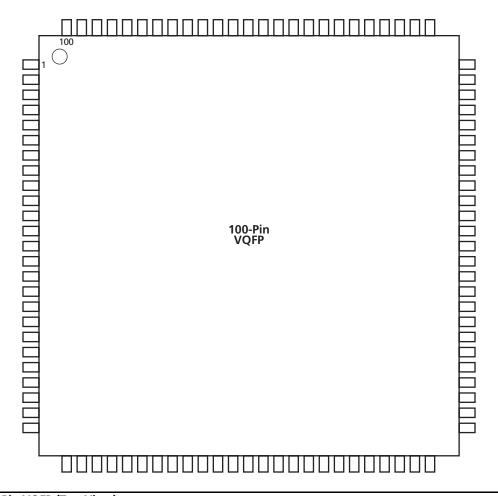


Figure 2-5 • 100-Pin VQFP (Top View)

Note

For Package Manufacturing and Environmental information, visit the Package Resource center at http://www.actel.com/products/rescenter/package/index.html.

2-14 v3.2

| 313-Pin PBGA | | |
|--------------|------------------|--|
| Pin | A54SX32 | |
| Number | Function | |
| H20 | I/O | |
| H22 | V_{CCI} | |
| H24 | I/O | |
| J1 | I/O | |
| J3 | 1/0 | |
| J5 | I/O | |
| J7 | NC | |
| J9 | I/O | |
| J11 | 1/0 | |
| J13 | CLKA | |
| J15 | I/O | |
| J17 | I/O | |
| J19 | 1/0 | |
| J21 | GND | |
| J23 | I/O | |
| J25 | I/O | |
| K2 | I/O | |
| K4 | I/O | |
| K6 | I/O | |
| K8 | V _{CCI} | |
| K10 | I/O | |
| K12 | I/O | |
| K14 | I/O | |
| K16 | I/O | |
| K18 | I/O | |
| K20 | V_{CCA} | |
| K22 | I/O | |
| K24 | I/O | |
| L1 | I/O | |
| L3 | I/O | |
| L5 | I/O | |
| L7 | I/O | |
| L9 | I/O | |
| L11 | I/O | |
| L13 | GND | |
| L15 | I/O | |
| L17 | I/O | |
| L19 | I/O | |
| L21 | I/O | |
| L23 | I/O | |

| 313-Pin PBGA Pin A54SX32 | | |
|--------------------------|--|--|
| A54SX32 Function | | |
| I/O | | |
| 1/0 | | |
| I/O | | |
| 1/0 | | |
| I/O | | |
| I/O | | |
| GND | | |
| GND | | |
| V _{CCI} | | |
| I/O | | |
| V_{CCA} | | |
| V_{CCR} | | |
| I/O | | |
| V _{CCI} | | |
| GND | | |
| GND | | |
| GND | | |
| I/O | | |
| I/O | | |
| I/O | | |
| V_{CCR} | | |
| V _{CCA} | | |
| I/O | | |
| GND | | |
| GND | | |
| I/O | | |
| I/O | | |
| NC | | |
| I/O | | |
| | | |

| 313-Pin PBGA | | |
|---------------|---------------------|--|
| Pin Number | A54SX32 Function | |
| R5 | I/O | |
| R7 | I/O | |
| R9 | 1/0 | |
| R11 | 1/0 | |
| R13 | GND | |
| R15 | 1/0 | |
| R17 | 1/0 | |
| R19 | 1/0 | |
| R21 | 1/0 | |
| R23 | I/O | |
| R25 | I/O | |
| T2 | I/O | |
| T4 | I/O | |
| T6 | I/O | |
| Т8 | I/O | |
| T10 | I/O | |
| T12 | I/O | |
| T14 | HCLK | |
| T16 | I/O | |
| T18 | I/O | |
| T20 | I/O | |
| T22 | I/O | |
| T24 | I/O | |
| U1 | I/O | |
| U3 | I/O | |
| U5 | V _{CCI} | |
| U7 | I/O | |
| U9 | I/O | |
| U11 | I/O | |
| U13 | I/O | |
| U15 | I/O | |
| U17 | I/O | |
| U19 | I/O | |
| U21 | I/O | |
| U23 | I/O | |
| U25 | I/O | |
| V2 | V _{CCA} | |
| V4 | I/O | |
| V6 | I/O | |
| V8 | I/O | |

| 313-Pin PBGA | | |
|--------------|------------------|--|
| Pin | A54SX32 | |
| Number | Function | |
| V10 | I/O | |
| V12 | I/O | |
| V14 | I/O | |
| V16 | NC | |
| V18 | I/O | |
| V20 | I/O | |
| V22 | V_{CCA} | |
| V24 | V _{CCI} | |
| W1 | I/O | |
| W3 | I/O | |
| W5 | I/O | |
| W7 | NC | |
| W9 | I/O | |
| W11 | I/O | |
| W13 | V _{CCI} | |
| W15 | I/O | |
| W17 | I/O | |
| W19 | I/O | |
| W21 | I/O | |
| W23 | I/O | |
| W25 | I/O | |
| Y2 | I/O | |
| Y4 | I/O | |
| Y6 | I/O | |
| Y8 | I/O | |
| Y10 | I/O | |
| Y12 | I/O | |
| Y14 | I/O | |
| Y16 | 1/0 | |
| Y18 | 1/0 | |
| Y20 | NC | |
| Y22 | I/O | |
| Y24 | NC | |

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| 329-Pin PBGA | | |
|---------------|---------------------|--|
| Pin Number | A54SX32 Function | |
| A1 | GND | |
| A2 | GND | |
| А3 | V _{CCI} | |
| A4 | NC | |
| A5 | I/O | |
| A6 | I/O | |
| A7 | V _{CCI} | |
| A8 | NC | |
| A9 | I/O | |
| A10 | I/O | |
| A11 | I/O | |
| A12 | I/O | |
| A13 | CLKB | |
| A14 | I/O | |
| A15 | I/O | |
| A16 | I/O | |
| A17 | I/O | |
| A18 | 1/0 | |
| A19 | I/O | |
| A20 | I/O | |
| A21 | NC | |
| A22 | V _{CCI} | |
| A23 | GND | |
| AA1 | V _{CCI} | |
| AA2 | I/O | |
| AA3 | GND | |
| AA4 | I/O | |
| AA5 | 1/0 | |
| AA6 | I/O | |
| AA7 | I/O | |
| AA8 | I/O | |
| AA9 | I/O | |
| AA10 | I/O | |
| AA11 | I/O | |
| AA12 | 1/0 | |

| 329-Pin PBGA | | |
|---------------|---------------------|--|
| Pin Number | A54SX32 Function | |
| AA13 | 1/0 | |
| AA14 | 1/0 | |
| AA15 | I/O | |
| AA16 | I/O | |
| AA17 | 1/0 | |
| AA18 | I/O | |
| AA19 | I/O | |
| AA20 | TDO, I/O | |
| AA21 | V _{CCI} | |
| AA22 | 1/0 | |
| AA23 | V _{CCI} | |
| AB1 | 1/0 | |
| AB2 | GND | |
| AB3 | 1/0 | |
| AB4 | 1/0 | |
| AB5 | 1/0 | |
| AB6 | 1/0 | |
| AB7 | 1/0 | |
| AB8 | 1/0 | |
| AB9 | 1/0 | |
| AB10 | 1/0 | |
| AB11 | PRB, I/O | |
| AB12 | 1/0 | |
| AB13 | HCLK | |
| AB14 | 1/0 | |
| AB15 | 1/0 | |
| AB16 | 1/0 | |
| AB17 | 1/0 | |
| AB18 | 1/0 | |
| AB19 | 1/0 | |
| AB20 | I/O | |
| AB21 | I/O | |
| AB22 | GND | |
| AB23 | 1/0 | |
| AC1 | GND | |

| 329-Pin PBGA | | |
|---------------|---------------------|--|
| Pin Number | A54SX32 Function | |
| AC2 | V _{CCI} | |
| AC3 | NC | |
| AC4 | 1/0 | |
| AC5 | I/O | |
| AC6 | I/O | |
| AC7 | I/O | |
| AC8 | I/O | |
| AC9 | V _{CCI} | |
| AC10 | I/O | |
| AC11 | I/O | |
| AC12 | I/O | |
| AC13 | I/O | |
| AC14 | I/O | |
| AC15 | NC | |
| AC16 | I/O | |
| AC17 | I/O | |
| AC18 | I/O | |
| AC19 | I/O | |
| AC20 | I/O | |
| AC21 | NC | |
| AC22 | V _{CCI} | |
| AC23 | GND | |
| B1 | V _{CCI} | |
| B2 | GND | |
| В3 | I/O | |
| В4 | I/O | |
| B5 | I/O | |
| В6 | I/O | |
| В7 | I/O | |
| B8 | I/O | |
| В9 | I/O | |
| B10 | I/O | |
| B11 | I/O | |
| B12 | PRA, I/O | |
| B13 | CLKA | |
| | | |

| 329-Pin PBGA | | |
|---------------|---------------------|--|
| Pin Number | A54SX32 Function | |
| B14 | 1/0 | |
| B15 | 1/0 | |
| B16 | | |
| | 1/0 | |
| B17 | 1/0 | |
| B18 | 1/0 | |
| B19 | 1/0 | |
| B20 | I/O | |
| B21 | I/O | |
| B22 | GND | |
| B23 | V _{CCI} | |
| C1 | NC | |
| C2 | TDI, I/O | |
| C3 | GND | |
| C4 | I/O | |
| C5 | I/O | |
| C6 | I/O | |
| C7 | I/O | |
| C8 | I/O | |
| С9 | I/O | |
| C10 | I/O | |
| C11 | I/O | |
| C12 | I/O | |
| C13 | I/O | |
| C14 | I/O | |
| C15 | I/O | |
| C16 | I/O | |
| C17 | I/O | |
| C18 | I/O | |
| C19 | I/O | |
| C20 | I/O | |
| C21 | V _{CCI} | |
| C22 | GND | |
| C23 | NC | |
| D1 | I/O | |
| D2 | I/O | |
| | | |

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| 144-Pin FBGA | | |
|---------------|---------------------|--|
| Pin Number | A54SX08 Function | |
| A1 | I/O | |
| A2 | I/O | |
| А3 | I/O | |
| A4 | I/O | |
| A5 | V_{CCA} | |
| A6 | GND | |
| A7 | CLKA | |
| A8 | I/O | |
| A9 | I/O | |
| A10 | I/O | |
| A11 | I/O | |
| A12 | I/O | |
| B1 | I/O | |
| B2 | GND | |
| В3 | I/O | |
| B4 | I/O | |
| B5 | I/O | |
| В6 | I/O | |
| В7 | CLKB | |
| B8 | I/O | |
| B9 | I/O | |
| B10 | 1/0 | |
| B11 | GND | |
| B12 | 1/0 | |
| C1 | I/O | |
| C2 | I/O | |
| C3 | TCK, I/O | |
| C4 | I/O | |
| C5 | I/O | |
| C6 | PRA, I/O | |
| C7 | I/O | |
| C8 | I/O | |
| C9 | I/O | |
| C10 | I/O | |
| C11 | I/O | |
| C12 | I/O | |
| | | |

| 144-Pin FBGA | | |
|---------------|---------------------|--|
| Pin Number | A545X08 Function | |
| D1 | 1/0 | |
| D2 | V _{CCI} | |
| D3 | TDI, I/O | |
| D4 | I/O | |
| D5 | I/O | |
| D6 | I/O | |
| D7 | I/O | |
| D8 | 1/0 | |
| D9 | 1/0 | |
| D10 | 1/0 | |
| D11 | I/O | |
| D12 | I/O | |
| E1 | I/O | |
| E2 | I/O | |
| E3 | I/O | |
| E4 | I/O | |
| E5 | TMS | |
| E6 | V _{CCI} | |
| E7 | V _{CCI} | |
| E8 | V _{CCI} | |
| E9 | V_{CCA} | |
| E10 | 1/0 | |
| E11 | GND | |
| E12 | 1/0 | |
| F1 | 1/0 | |
| F2 | 1/0 | |
| F3 | V_{CCR} | |
| F4 | 1/0 | |
| F5 | GND | |
| F6 | GND | |
| F7 | GND | |
| F8 | V _{CCI} | |
| F9 | I/O | |
| F10 | GND | |
| F11 | 1/0 | |
| F12 | 1/0 | |

| 144-Pin FBGA | | |
|---------------|---|--|
| Pin Number | A54SX08 Function | |
| G1 | I/O | |
| G2 | GND | |
| G3 | I/O | |
| G4 | I/O | |
| G5 | GND | |
| G6 | GND | |
| G7 | GND | |
| G8 | V _{CCI} | |
| G9 | I/O | |
| G10 | I/O | |
| G11 | I/O | |
| G12 | I/O | |
| H1 | I/O | |
| H2 | I/O | |
| Н3 | I/O | |
| H4 | I/O | |
| H5 | V _{CCA} V _{CCA} V _{CCI} V _{CCI} | |
| H6 | V_{CCA} | |
| H7 | V _{CCI} | |
| Н8 | V _{CCI} | |
| H9 | V _{CCA} | |
| H10 | 1/0 | |
| H11 | 1/0 | |
| H12 | V_{CCR} | |
| J1 | 1/0 | |
| J2 | I/O | |
| J3 | I/O | |
| J4 | I/O | |
| J5 | 1/0 | |
| J6 | PRB, I/O | |
| J7 | I/O | |
| J8 | I/O | |
| J9 | I/O | |
| J10 | I/O | |
| J11 | I/O | |
| J12 | V_{CCA} | |

| 144-Piı | n FBGA |
|---------------|---------------------|
| Pin Number | A54SX08 Function |
| K1 | I/O |
| K2 | I/O |
| K3 | I/O |
| K4 | I/O |
| K5 | I/O |
| K6 | I/O |
| K7 | GND |
| K8 | I/O |
| К9 | I/O |
| K10 | GND |
| K11 | I/O |
| K12 | I/O |
| L1 | GND |
| L2 | I/O |
| L3 | I/O |
| L4 | I/O |
| L5 | I/O |
| L6 | I/O |
| L7 | HCLK |
| L8 | I/O |
| L9 | I/O |
| L10 | 1/0 |
| L11 | 1/0 |
| L12 | I/O |
| M1 | I/O |
| M2 | 1/0 |
| M3 | I/O |
| M4 | I/O |
| M5 | 1/0 |
| M6 | 1/0 |
| M7 | V_{CCA} |
| M8 | I/O |
| M9 | I/O |
| M10 | I/O |
| M11 | TDO, I/O |
| M12 | I/O |

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Datasheet Information

List of Changes

The following table lists critical changes that were made in the current version of the document.

| Previous Version | Changes in Current Version (v3.2) | Page |
|-------------------------|--|------|
| v3.1 | The "Ordering Information" was updated to include RoHS information. | 1-ii |
| (June 2003) | The Product Plan was removed since all products have been released. | N/A |
| | Information concerning the TRST pin in the "Probe Circuit Control Pins" section was removed. | 1-6 |
| | The "Dedicated Test Mode" section is new. | 1-6 |
| | The "Programming" section is new. | 1-7 |
| | A note was added to the "Power-Up Sequencing" table. | 1-15 |
| | A note was added to the "Power-Down Sequencing" table. The 3.3 V comments were updated for the following devices: A54SX08, A54SX16, A54SX32. | 1-15 |
| | U11 and U13 were added to the "313-Pin PBGA" table. | 2-17 |
| v3.0.1 | Storage temperature in Table 1-3 was updated. | 1-7 |
| | Table 1-1 was updated. | 1-5 |

Datasheet Categories

In order to provide the latest information to designers, some datasheets are published before data has been fully characterized. Datasheets are designated as "Product Brief," "Advanced," "Production," and "Datasheet Supplement." The definitions of these categories are as follows:

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The product brief is a summarized version of a datasheet (advanced or production) containing general product information. This brief gives an overview of specific device and family information.

Advanced

This datasheet version contains initial estimated information based on simulation, other products, devices, or speed grades. This information can be used as estimates, but not for production.

Unmarked (production)

This datasheet version contains information that is considered to be final.

Datasheet Supplement

The datasheet supplement gives specific device information for a derivative family that differs from the general family datasheet. The supplement is to be used in conjunction with the datasheet to obtain more detailed information and for specifications that do not differ between the two families.

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